Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/766,971	BONG, YIN YEN
Examiner	Art Unit
Chris C. Chu	2815

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	SEARCHED				
Class	Subclass	Date	Examiner		
257	678, 679, 684, 690, 698 & 783	11/23/2005	C.C.		
343	700MS	11/23/2005	C.C.		
343	895	11/23/2005	C.C.		
235	441	11/23/2005	C.C.		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; and IBM_TDB;	11/23/2005	C.C.		